N-Channel UniFET MOSFET

200 V, 52 A, 49 m Ω

Description

UniFET MOSFET is ON Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on–state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.

Features

- $R_{DS(on)} = 41 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V}, I_D = 26 \text{ A}$
- Low Gate Charge (Typ. 49 nC)
- Low C_{RSS} (Typ. 66 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

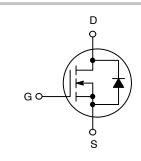
- PDP TV
- Lighting
- Uninterruptible Power Supply
- AC-DC Power Supply



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ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, Unless otherwise specified)

Symbol	Parameter		Value	Unit
V _{DSS}	Drain to Source Voltage		200	V
V_{GSS}	Gate to Source Voltage		±30	V
I _D	Drain Current	Continuous (T _C = 25°C)	52	Α
		Continuous (T _C = 100°C)	33]
I _{DM}	Drain Current	Pulsed (Note 1)	208	А
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		2520	mJ
I _{AR}	Avalanche Current (Note 1)		52	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)		35.7	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns
P_{D}	Power Dissipation	(T _C = 25°C)	357	W
		Derate Above 25°C	2.86	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	perating and Storage Temperature Range		°C
T_L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 s		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
 2. L = 1.4 mH, I_{AS} = 52 A, V_{DD} = 50 V, R_G = 25 Ω , starting T_J = 25°C.
 3. I_{SD} \leq 52 A, di/dt \leq 200 A/ μ s, V_{DD} \leq BV_{DSS}, starting T_J = 25°C.
 4. Essentially independent of operating temperature typical characteristics.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.35	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	

PACKAGE MARKING AND ORDERING INFORMATION

I	Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
	FDP52N20	FDP52N20	TO-220	Tube	N/A	N/A	50 Units

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS		•	•		
BV _{DSS}	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A, } T_J = 25^{\circ}\text{C}$	200	-	_	V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C	-	0.2	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 200 V, V _{GS} = 0 V	-	-	1	μΑ
		V _{DS} = 160 V, T _C = 125°C	_	-	10	
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	±100	nA
ON CHARACTE	ERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250 \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 26 A	-	0.041	0.049	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 26 A	_	35	_	S
DYNAMIC CHA	RACTERISTICS					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	2230	2900	pF
C _{oss}	Output Capacitance		-	540	700	pF
C _{rss}	Reverse Transfer Capacitance		-	66	100	pF
Q _{g(tot)}	Total Gate Charge at 10 V	$V_{DS} = 160 \text{ V}, I_D = 52 \text{ A}, V_{GS} = 10 \text{ V}$ (Note 5)	_	49	63	nC
Q_{gs}	Gate to Source Gate Charge		-	19	_	nC
Q_{gd}	Gate to Drain "Miller" Charge		_	24	_	nC
SWITCHING CH	HARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 100 \text{ V}, I_D = 20 \text{ A},$	-	53	115	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega \text{ (Note 5)}$	-	175	359	ns
t _{d(off)}	Turn-Off Delay Time		-	48	107	ns
t _f	Turn-Off Fall Time		-	29	68	ns
DRAIN-SOURC	CE DIODE CHARACTERISTICS					
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	52	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	204	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 52 A	-	_	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 52 A,	-	162	_	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100 A/μs	_	1.3	_	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Essentially independent of operating temperature typical characteristics.

TYPICAL PERFORMANCE CHARACTERISTICS

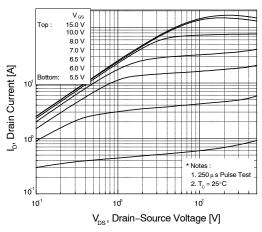


Figure 1. On-Region Characteristics

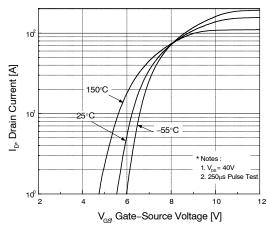


Figure 2. Transfer Characteristics

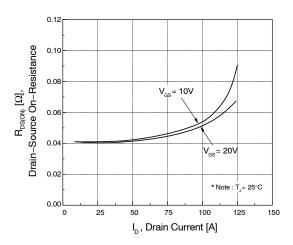


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

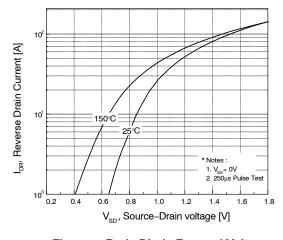


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

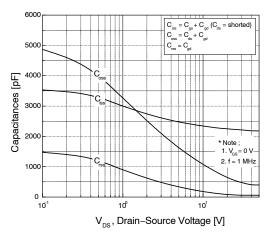


Figure 5. Capacitance Characteristics

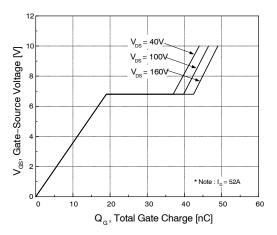


Figure 6. Gate Charge Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS

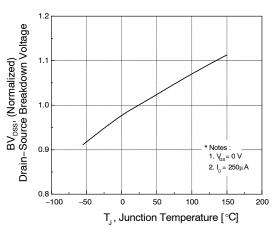


Figure 7. Breakdown Voltage Variation vs. Temperature

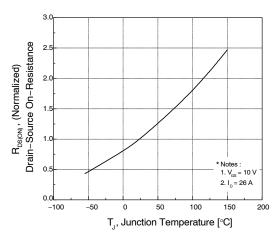


Figure 8. On-Resistance Variation vs. Temperature

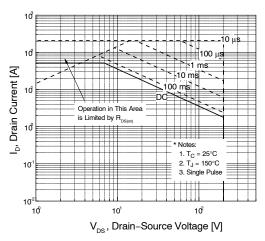


Figure 9. Maximum Safe Operation Area

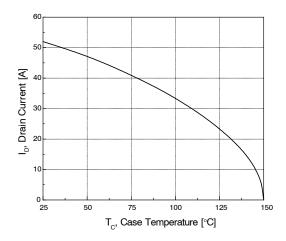


Figure 10. Maximum Drain Current

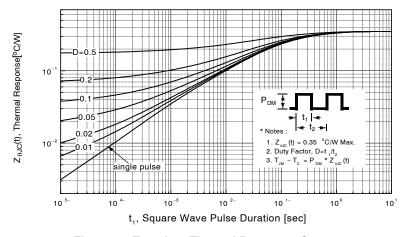


Figure 11. Transient Thermal Response Curve

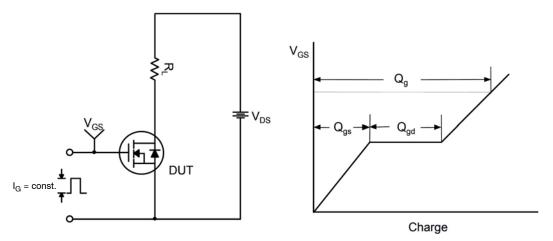


Figure 12. Gate Charge Test Circuit & Waveform

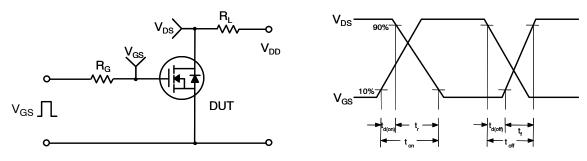


Figure 13. Resistive Switching Test Circuit & Waveforms

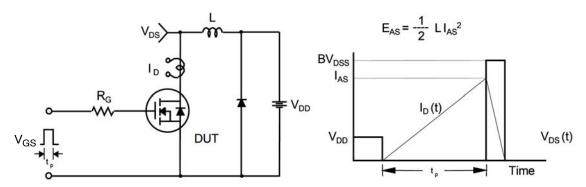
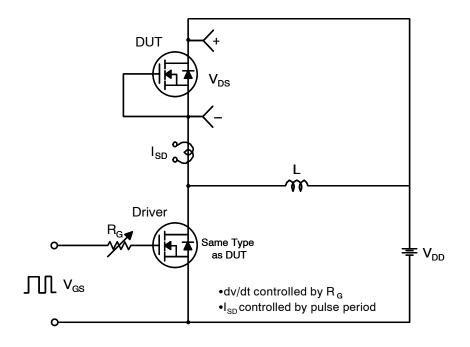


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



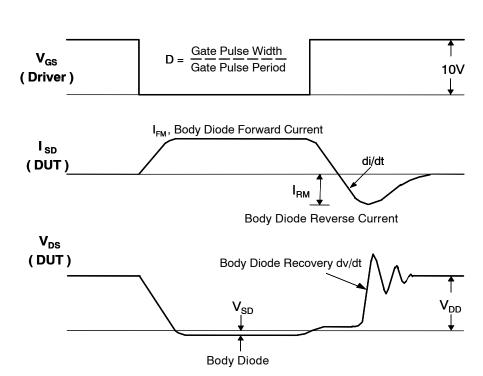
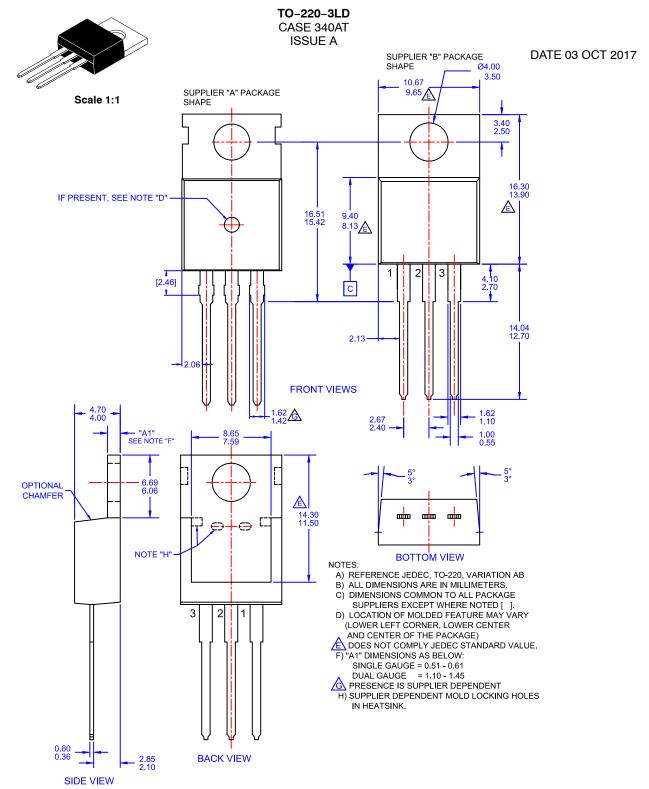


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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